0	Ø. 79		•
-	S		
N - 18	S. 18		•
Α,	0		
			Ŧ
179.00			
Ø	B		*
	n		
17-	2		3
(D)	- 4	_	
	3		Ī
0			
mc	==> €		ı
O T	*** &		Š
Ü	30.00	-	ė
2 - 1	32962		•

· 新文·

PATENT NUMBER and ISSUE DATE

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU 2133	EXAMINER	
10065365	10/09/2002	324-1	727	2858	BRITT	
**APPLICANT	S: Basset	t Robert; C	hristensen G	arrett; Co	mbs Michael; Farnsworth L.;	
Gillis Pamela;ℓ	(17		RSD			
			/ (J.			
			•			
-CONTINUING	DATA VERIFIE	D:#/>				
FORFIGN AD	PLICATIONS VEI	DIELED				
TORLIGIT AF	FLICATIONS VEI	RIFIED:	15		•	
	T PUBLISH 🗖		RESCINE			
reign priority claime USC 119 condition	ed	☐ yes 万	3/10		ATTORNEY DOCKET NO	_
rified and Acknowle	ns met edged Examiners's inti	□ yes □	tho	le	BUR920010209	
LE : Parametri	c testing for high	pin count	ASIC		701020010209	_
			-		U.S.DEPT. OF COMM./PAT.& TM-PTO-436L(Rev. 1	2-94)
		go.z				
OF ALLOWAN	1 459 A 45 T	May filter for				* 0 %
O ALLOWAN	CE MAILED	Z X			CLAIMS ALLOWED)
		Assistant	Framinar			lain
ISSUE FE			20 10 000 00 00 00 00 00 00 00 00 00 00 0	3 0	0.G	Š
	e Pald				Sheets Drwg. Figs.Drwg.	Print
CONTRACTOR OF THE PROPERTY OF	STEP SET SE		Primary	Examine		Territory.
The second second	、 及公公"经上"、等	1. Ku mg 14. 112.	2 2 44	1000	计图像设置设置的 医克里	
TERMINA	一种不必须	Paso	ARED FOR	CIIE *	Application Evanian	
TERMINA	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1		ARED FOR IS		Application Examiner sed herein may be restricted.	, w

DISK (CRF) CD-ROM (Attached in pocket on right inside flap)